Notice of References Cited Application/Control No. O9/518,695 Examiner David Odland Applicant(s)/Patent Under Reexamination YI, SEUNG-HEE Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,953,316	09-1999	Lazar et al.	370/230
	В	US-			
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	O	US-			·
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

	MON-FATENT DOCUMENTS					
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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	V					
	w					
	х					

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